

CD4724B Types

CMOS 8-Bit Addressable Latch

NOT RECOMMENDED FOR NEW DESIGNS
SEE CD4099B

High-Voltage Types (20-Volt Rating)

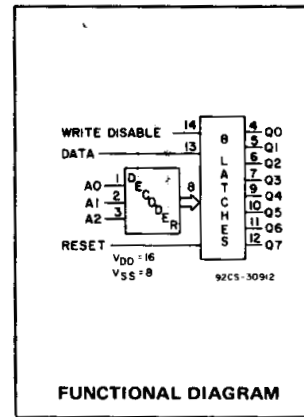
■ CD4724B 8-bit addressable latch is a serial-input, parallel-output storage register that can perform a variety of functions.

Data are inputted to a particular bit in the latch when that bit is addressed (by means of inputs A0, A1, A2) and when WRITE DISABLE is at a low level. When WRITE DISABLE is high, data entry is inhibited; however, all 8 outputs can be continuously read independent of WRITE DISABLE and address inputs.

A master RESET input is available, which resets all bits to a logic "0" level when RESET and WRITE DISABLE are at a high level. When RESET is at a high level, and WRITE DISABLE is at a low level, the latch acts as a 1-of-8 demultiplexer; the bit that is addressed has an active output which follows the data input, while all unaddressed bits are held to a logic "0" level.

The CD4724B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (NSR suffix), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

- Serial data input
- Active parallel output
- Storage register capability
- Master clear
- Can function as demultiplexer
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- Maximum input current of 1 μ A at 18 V (full package-temperature range), 100 nA at 18 V and 25°C
- Noise margin (full package-temperature range) = 1 V at $V_{DD} = 5$ V, 2 V at $V_{DD} = 10$ V, 2.5 V at $V_{DD} = 15$ V
- 5-V, 10-V, and 15-V parametric ratings
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"



- Applications:**
- Multi-line decoders
 - A/D converters

MAXIMUM RATINGS, Absolute-Maximum Values:

| | |
|--|--|
| DC SUPPLY-VOLTAGE RANGE, (V_{DD}) | -0.5V to +20V |
| (Voltages referenced to V_{SS} Terminal) | |
| INPUT VOLTAGE RANGE, ALL INPUTS | -0.5V to $V_{DD} + 0.5$ V |
| DC INPUT CURRENT, ANY ONE INPUT | ± 10 mA |
| POWER DISSIPATION PER PACKAGE (P_D): | |
| For $T_A = -55^\circ\text{C}$ to $+125^\circ\text{C}$ | 500mW |
| For $T_A = +100^\circ\text{C}$ to $+125^\circ\text{C}$ | Derate Linearly at 12mW/ $^\circ\text{C}$ to 200mW |
| DEVICE DISSIPATION PER OUTPUT TRANSISTOR | |
| FOR $T_A =$ FULL PACKAGE-TEMPERATURE RANGE (All Package Types) | 100mW |
| OPERATING-TEMPERATURE RANGE (T_A) | -55°C to $+125^\circ\text{C}$ |
| STORAGE TEMPERATURE RANGE (T_{stg}) | -65°C to $+150^\circ\text{C}$ |
| LEAD TEMPERATURE (DURING SOLDERING): | |
| At distance 1/16 \pm 1/32 inch (1.59 \pm 0.79mm) from case for 10s max | $+265^\circ\text{C}$ |

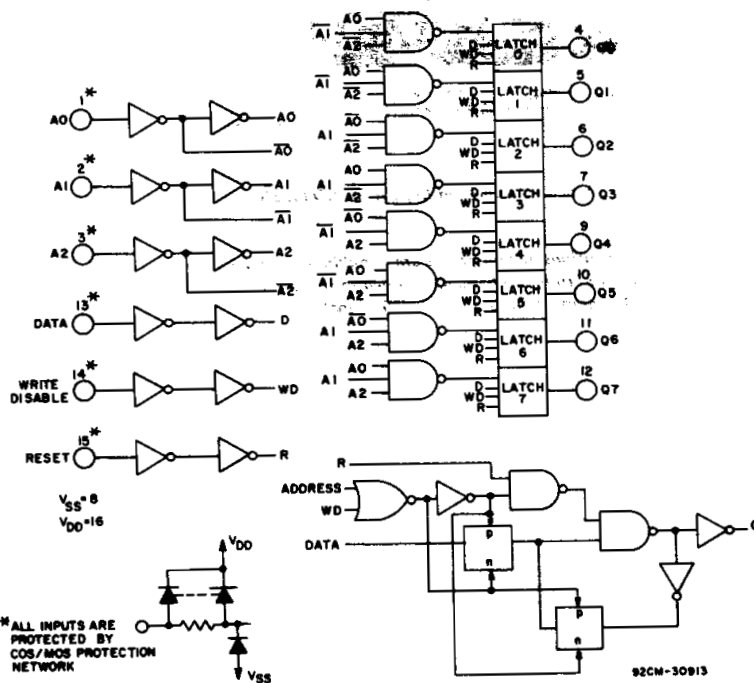


Fig. 1— Logic diagram of CD4724B and detail of 1 of 8 latches.

TERMINAL ASSIGNMENT

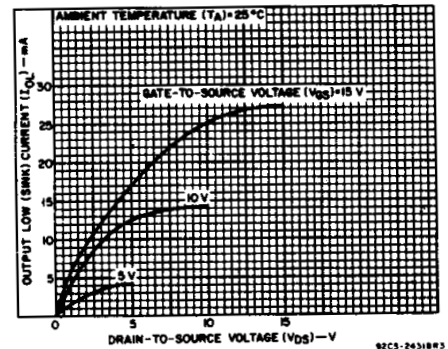
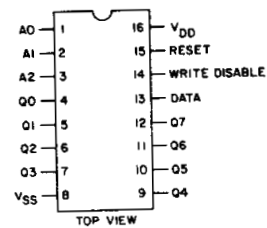


Fig. 2— Typical output low (sink) current characteristics.

CD4724B Types

RECOMMENDED OPERATING CONDITIONS at $T_A = 25^\circ\text{C}$ (Unless otherwise specified)
 For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

| CHARACTERISTIC | SEE FIG. 15* | VDD (V) | LIMITS | | UNITS |
|--|--------------|---------|--------|------|-------|
| | | | MIN. | MAX. | |
| Supply Voltage Range: (At $T_A = \text{Full Package Temperature Range}$) | | | 3 | 18 | V |
| Pulse Width, t_W Data | 4 | 5 | 200 | — | ns |
| | | 10 | 100 | — | |
| | | 15 | 80 | — | |
| Address | 8 | 5 | 400 | — | ns |
| | | 10 | 200 | — | |
| | | 15 | 125 | — | |
| Reset | 5 | 5 | 150 | — | ns |
| | | 10 | 75 | — | |
| | | 15 | 50 | — | |
| Setup Time, t_S Data to WRITE DISABLE | 6 | 5 | 100 | — | ns |
| | | 10 | 50 | — | |
| | | 15 | 35 | — | |
| Hold Time, t_H Data to WRITE DISABLE | 7 | 5 | 150 | — | ns |
| | | 10 | 75 | — | |
| | | 15 | 50 | — | |

* Circled numbers refer to times indicated on master timing diagram.

Note: In addition to the above characteristics, a WRITE DISABLE ON time (the time that WRITE DISABLE is at a high level) must be observed during an address change for the total time that the external address lines A0, A1, and A2 are setting to a stable level, to prevent a wrong cell from being addressed.

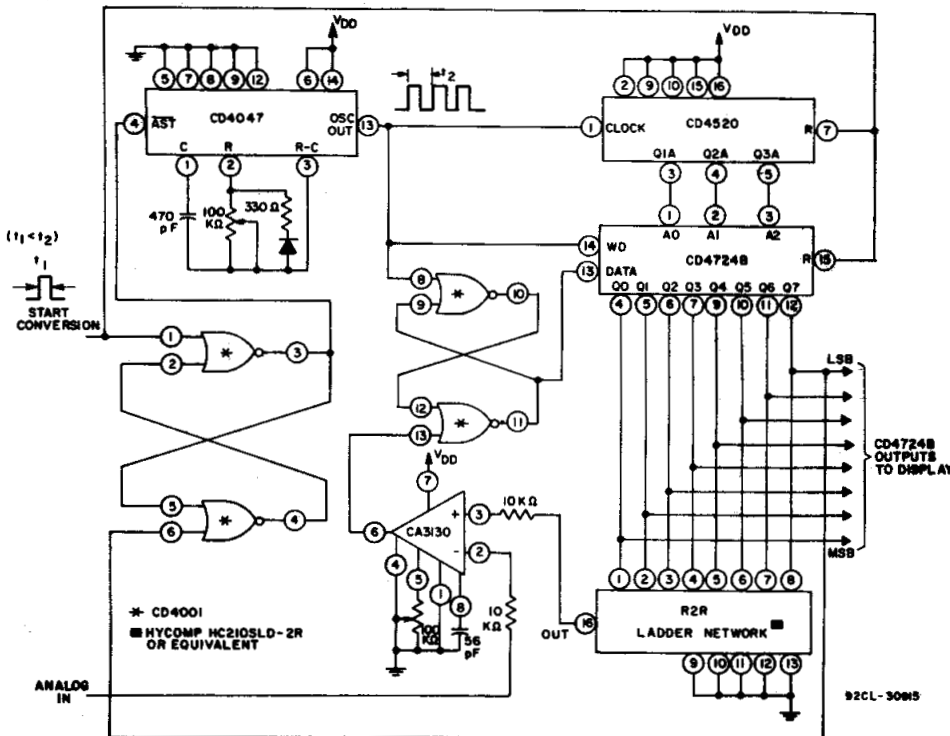
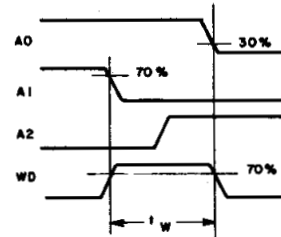


Fig. 5— A/D converter

| MODE SELECTION | | | |
|----------------|---|--|----------------------|
| WD | R | ADDRESSED LATCH | UNADDRESSED LATCH |
| 0 | 0 | Follows Data | Holds Previous State |
| 0 | 1 | Follows Data (Active High 8-Channel Demultiplexer) | Reset to "0" |
| 1 | 0 | Holds Previous State | |
| 1 | 1 | Reset to "0" | Reset to "0" |

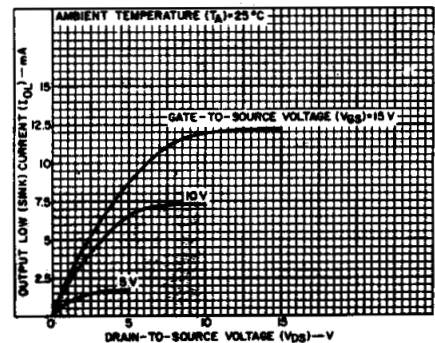
WD = WRITE DISABLE

R = RESET



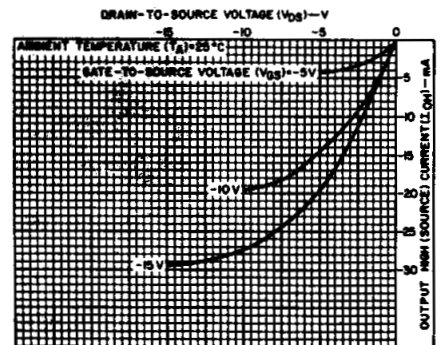
92CS-27676R1

Fig. 3— Definition of WRITE DISABLE ON time.



92CS-24319R1

Fig. 4— Minimum output low (sink) current characteristics.



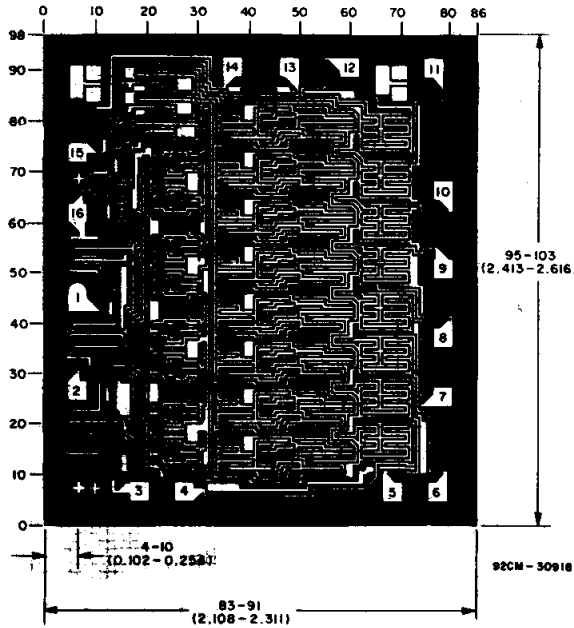
92CS-24320R3

Fig. 6— Typical output high (source) current characteristics.

CD4724B Types

STATIC ELECTRICAL CHARACTERISTICS

| CHARACTERISTIC | CONDITIONS | | | LIMITS AT INDICATED TEMPERATURES (°C) | | | | | | | UNITS |
|--|--------------------|---------------------|---------------------|---------------------------------------|-------|-------|-------|-------|-------------------|------|-------|
| | V _O (V) | V _{IN} (V) | V _{DD} (V) | -55 | -40 | +85 | +125 | +25 | | | |
| | | | | | | | | Min. | Typ. | Max. | |
| Quiescent Device Current, I _{DD} Max. | - | 0,5 | 5 | 5 | 5 | 150 | 150 | - | 0.04 | 5 | μA |
| | - | 0,10 | 10 | 10 | 10 | 300 | 300 | - | 0.04 | 10 | |
| | - | 0,15 | 15 | 20 | 20 | 600 | 600 | - | 0.04 | 20 | |
| | - | 0,20 | 20 | 100 | 100 | 3000 | 3000 | - | 0.08 | 100 | |
| Output Low (Sink) Current I _{OL} Min. | 0.4 | 0,5 | 5 | 0.64 | 0.61 | 0.42 | 0.36 | 0.51 | 1 | - | mA |
| | 0.5 | 0,10 | 10 | 1.6 | 1.5 | 1.1 | 0.9 | 1.3 | 2.6 | - | |
| | 1.5 | 0,15 | 15 | 4.2 | 4 | 2.8 | 2.4 | 3.4 | 6.8 | - | |
| Output High (Source) Current, I _{OH} Min. | 4.6 | 0,5 | 5 | -0.64 | -0.61 | -0.42 | -0.36 | -0.51 | -1 | - | mA |
| | 2.5 | 0,5 | 5 | -2 | -1.8 | -1.3 | -1.15 | -1.6 | -3.2 | - | |
| | 9.5 | 0,10 | 10 | -1.6 | -1.5 | -1.1 | -0.9 | -1.3 | -2.6 | - | |
| | 13.5 | 0,15 | 15 | -4.2 | -4 | -2.8 | -2.4 | -3.4 | -6.8 | - | |
| Output Voltage: Low-Level, V _{OL} Max. | - | 0,5 | 5 | 0.05 | | | | - | 0 | 0.05 | V |
| | - | 0,10 | 10 | 0.05 | | | | - | 0 | 0.05 | |
| | - | 0,15 | 15 | 0.05 | | | | - | 0 | 0.05 | |
| Output Voltage: High-Level, V _{OH} Min. | - | 0,5 | 5 | 4.95 | | | | 4.95 | 5 | - | V |
| | - | 0,10 | 10 | 9.95 | | | | 9.95 | 10 | - | |
| | - | 0,15 | 15 | 14.95 | | | | 14.95 | 15 | - | |
| Input Low Voltage, V _{IL} Max. | 0.5, 4.5 | - | 5 | 1.5 | | | | - | - | 1.5 | V |
| | 1, 9 | - | 10 | 3 | | | | - | - | 3 | |
| | 1.5, 13.5 | - | 15 | 4 | | | | - | - | 4 | |
| Input High Voltage, V _{IH} Min. | 0.5, 4.5 | - | 5 | 3.5 | | | | 3.5 | - | - | V |
| | 1, 9 | - | 10 | 7 | | | | 7 | - | - | |
| | 1.5, 13.5 | - | 15 | 11 | | | | 11 | - | - | |
| Input Current I _{IN} Max. | - | 0,18 | 18 | ±0.1 | ±0.1 | ±1 | ±1 | - | ±10 ⁻⁵ | ±0.1 | μA |



CD4724BH DIMENSIONS AND PAD LAYOUT

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10⁻³ inch).

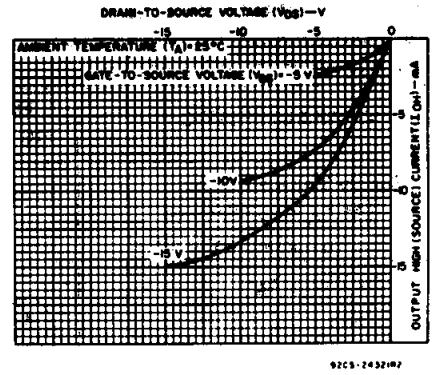


Fig. 7 - Minimum output high (source) current characteristics.

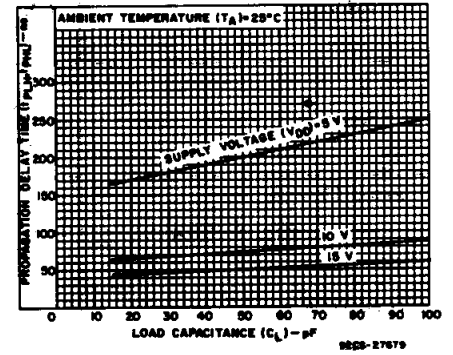


Fig. 8 - Typical propagation delay time (data to Q_n) vs. load capacitance.

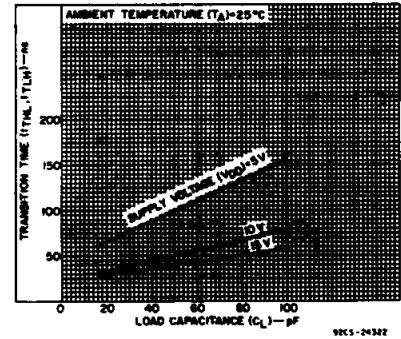


Fig. 9 - Typical transition time vs. load capacitance.

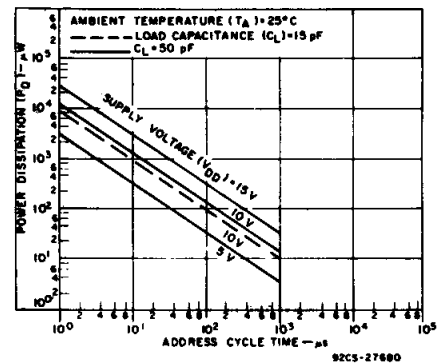


Fig. 10 - Typical dynamic power dissipation vs. address cycle time.

CD4724B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at $T_A = 25^\circ\text{C}$, $C_L = 50\text{ pF}$,
 Input $t_r, t_f = 20\text{ ns}$, $R_L = 200\text{ K}\Omega$

| CHARACTERISTIC | CONDITIONS | | LIMITS ALL PACKAGE TYPES | | UNITS |
|---|-----------------|------------------------|-----------------------------|------|-------|
| | SEE Fig. 15* | V _{DD} (V) | TYP. | MAX. | |
| Propagation Delay: t_{PLH} , t_{PHL} | ① | 5 | 200 | 400 | ns |
| | | 10 | 75 | 150 | |
| | | 15 | 50 | 100 | |
| Data to Output, WRITE DISABLE to Output, t_{PLH} , t_{PHL} | ② | 5 | 200 | 400 | |
| 10 | | 80 | 160 | | |
| 15 | | 60 | 120 | | |
| Reset to Output, t_{PHL} | ③ | 5 | 175 | 350 | |
| | | 10 | 80 | 160 | |
| | | 15 | 65 | 130 | |
| Address to Output, t_{PLH} , t_{PHL} | ④ | 5 | 225 | 450 | |
| | | 10 | 100 | 200 | |
| | | 15 | 75 | 150 | |
| Transition Time, (Any Output) t_{THL} , t_{TLH} | | 5 | 100 | 200 | ns |
| | | 10 | 50 | 100 | |
| | | 15 | 40 | 80 | |
| Minimum Pulse Width, t_W Data | ⑤ | 5 | 100 | 200 | ns |
| | | 10 | 50 | 100 | |
| | | 15 | 40 | 80 | |
| Address | ⑥ | 5 | 200 | 400 | ns |
| | | 10 | 100 | 200 | |
| | | 15 | 65 | 125 | |
| Reset | ⑦ | 5 | 75 | 150 | ns |
| | | 10 | 40 | 75 | |
| | | 15 | 25 | 50 | |
| Minimum Setup Time, t_S Data to WRITE DISABLE | ⑧ | 5 | 50 | 100 | ns |
| | | 10 | 25 | 50 | |
| | | 15 | 20 | 35 | |
| Minimum Hold Time, t_H Data to WRITE DISABLE | ⑨ | 5 | 75 | 150 | ns |
| | | 10 | 40 | 75 | |
| | | 15 | 25 | 50 | |
| Input Capacitance, C_{IN} | Any Input | | 5 | 7.5 | pF |

*Circled numbers refer to times indicated on master timing diagram.

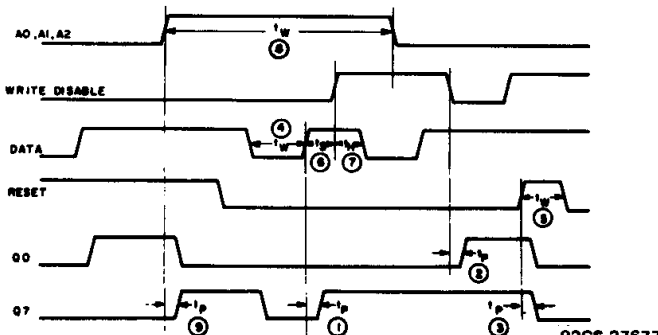


Fig. 15— Master timing diagram.

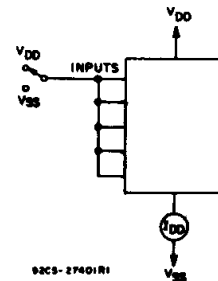


Fig. 11— Quiescent device current test circuit.

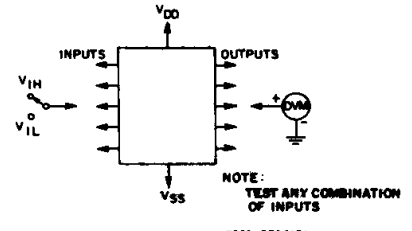


Fig. 12— Input voltage test circuit.

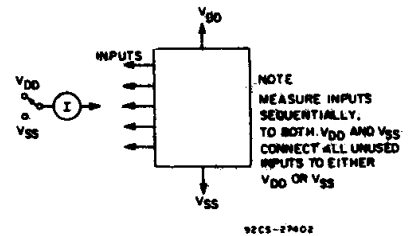


Fig. 13— Input current test circuit.

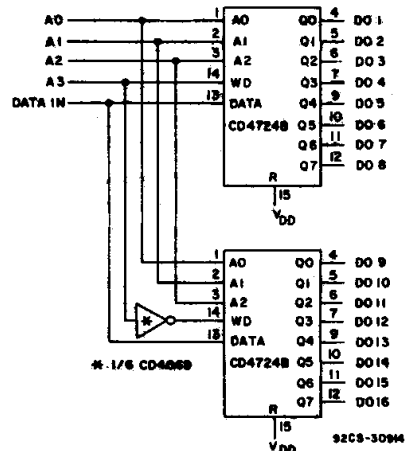


Fig. 14— 1 of 16 decoder/demultiplexer.

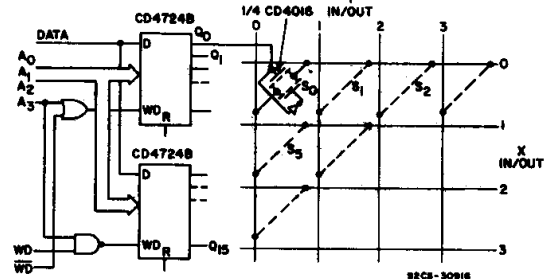


Fig. 16— Multiple selection decoding — 4 x 4 crosspoint switch.

3
 COMMERCIAL CMOS
 HIGH VOLTAGE ICs

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|------------------|----------------------|--------------|-------------------------|-------------------------|
| CD4724BE | ACTIVE | PDIP | N | 16 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD4724BE | Samples |
| CD4724BEE4 | ACTIVE | PDIP | N | 16 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD4724BE | Samples |
| CD4724BF3A | ACTIVE | CDIP | J | 16 | 1 | TBD | A42 | N / A for Pkg Type | -55 to 125 | CD4724BF3A | Samples |
| CD4724BPWRE4 | NRND | TSSOP | PW | 16 | | TBD | Call TI | Call TI | -55 to 125 | | |
| CD4724BPWRG4 | NRND | TSSOP | PW | 16 | | TBD | Call TI | Call TI | -55 to 125 | | |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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OTHER QUALIFIED VERSIONS OF CD4724B, CD4724B-MIL :

- Catalog: [CD4724B](#)
- Military: [CD4724B-MIL](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

J (R-GDIP-T**)

14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



| DIM \ PINS ** | 14 | 16 | 18 | 20 |
|---------------|------------------------|------------------------|------------------------|------------------------|
| A | 0.300 (7,62) BSC | 0.300 (7,62) BSC | 0.300 (7,62) BSC | 0.300 (7,62) BSC |
| B MAX | 0.785 (19,94) | .840 (21,34) | 0.960 (24,38) | 1.060 (26,92) |
| B MIN | — | — | — | — |
| C MAX | 0.300 (7,62) | 0.300 (7,62) | 0.310 (7,87) | 0.300 (7,62) |
| C MIN | 0.245 (6,22) | 0.245 (6,22) | 0.220 (5,59) | 0.245 (6,22) |



4040083/F 03/03

- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - This package is hermetically sealed with a ceramic lid using glass frit.
 - Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
 - Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
 - The 20 pin end lead shoulder width is a vendor option, either half or full width.

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